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IN THE UNITED STATES PATENT & TRADEMARK OFFICE

Applicants: Michael HAUSMANN, et al.

Serial No.: 09/462,435

Filed: January 7, 2000

For: **WAVE FIELD MICROSCOPE, METHOD FOR A WAVE FIELD MICROSCOPE, INCLUDING FOR DNA SEQUENCING, AND CALIBRATION METHOD FOR WAVE FIELD MICROSCOPY**

Art Unit: 2878

REQUEST FOR CORRECTED FILING RECEIPT

BOX: Office of Initial Patent Examination's
Customer Service Center
Assistant Commissioner for Patents
Washington, DC 20231

November 6, 2000

Sir:

We have received a filing receipt, dated September 25, 2000, for the above-identified application. As indicated on the enclosed copy in red ink, please make the following corrections: (1) the filing date: June 19, 2000 should be "January 7, 2000"; and (2) filing fees received to date: \$983.00 should be "\$1,078.00".

Applicants respectfully request that a corrected filing receipt be issued.

I hereby certify that this correspondence and/or documents referred to as attached therein and/or fee are being deposited with the United States Postal Service as "First Class mail" in an envelope addressed to "Assistant Commissioner for Patents, Washington, D.C. 20231" on November 6, 2000.

DAVIDSON, DAVIDSON & KAPPEL, LLP

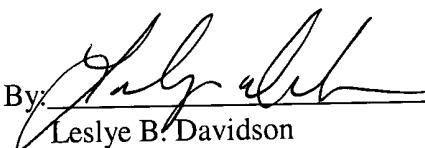
BY:

Barbara E. Fortini

Thank you for your prompt attention to this matter.

Respectfully submitted,

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APPLICATION NUMBER	FILING DATE	GRP ART UNIT	FIL FEE REC'D	ATTY.DOCKET.NO	DRAWINGS	TOT CLAIMS	IND CLAIMS
09/462,435	06/19/2000	2878	983	113.1004		16	4

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1,078

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CORRECTED FILING RECEIPT



OC000000005418713

Date Mailed: 09/22/2000

Receipt is acknowledged of this nonprovisional Patent Application. It will be considered in its order and you will be notified as to the results of the examination. Be sure to provide the U.S. APPLICATION NUMBER, FILING DATE, NAME OF APPLICANT, and TITLE OF INVENTION when inquiring about this application. Fees transmitted by check or draft are subject to collection. Please verify the accuracy of the data presented on this receipt. If an error is noted on this Filing Receipt, please write to the Office of Initial Patent Examination's Customer Service Center. Please provide a copy of this Filing Receipt with the changes noted thereon. If you received a "Notice to File Missing Parts" for this application, please submit any corrections to this Filing Receipt with your reply to the Notice. When the PTO processes the reply to the Notice, the PTO will generate another Filing Receipt incorporating the requested corrections (if appropriate).

Applicant(s)

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SEP 25 2000

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Continuing Data as Claimed by Applicant

THIS APPLICATION IS A 371 OF PCT/DE98/01908 07/09/1998

Foreign Applications

GERMANY 197 29 512.6 07/10/1997

If Required, Foreign Filing License Granted 07/10/2000

Title

WAVE FIELD MICROSCOPE, METHOD FOR A WAVE FIELD MICROSCOPE, INCLUDING FOR DNA SEQUENCING, AND CALIBRATION METHOD FOR WAVE FIELD MICROSCOPY

Preliminary Class

250

Data entry by : STEVENSON, SULONDA

Team : 2800

Date: 09/22/2000

